



Search Notes 	Application/Control No. 10665120	Applicant(s)/Patent Under Reexamination MIYAZAWA, TAKASHI
	Examiner Lui, Donna V	Art Unit 2629


Notes	Date	Examiner
345/204-206, 211-215, 690, 55, 82-84 East Text Search (US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB)	10/16/2006	DL
345 Class East Text Search (US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB)	10/16/2006	DL

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<p style="text-align: center;">Searched</p> 	<p>Application/Control No.</p> <p>10665120</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>MIYAZAWA, TAKASHI</p>
	<p>Examiner</p> <p>Lui, Donna V</p>	<p>Art Unit</p> <p>2629</p>

Class	SubClass	Date	Examiner
345	55	10/16/2006	DL
345	204	10/16/2006	DL

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